

PRODUCT FEATURES

- IGBT Chip(IGBT³ Trench+Field Stop technology), Diode Chip(Emcon3 wheeling diode)
- High level of integration—only one power semiconductor module required for the whole drive
- Low saturation voltage and positive temperature coefficient
- Fast switching and short tail current
- Free wheeling diodes with fast and soft reverse recovery
- Industry standard package with insulated copper base plate and soldering pins for PCB mounting
- Temperature sense included



APPLICATIONS

- AC motor control
- Motion/servo control
- Inverter and power supplies

IGBT-inverter

ABSOLUTE MAXIMUM RATINGS($T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Values	Unit
V_{CES}	Collector Emitter Voltage	$T_J=25^\circ\text{C}$	1200	V
V_{GES}	Gate Emitter Voltage		± 20	
I_C	DC Collector Current	$T_C=25^\circ\text{C}$	200	A
		$T_C=80^\circ\text{C}$	150	
I_{CM}	Repetitive Peak Collector Current	$t_p=1\text{ms}$	300	
P_{tot}	Power Dissipation Per IGBT		625	

Diode-inverter

ABSOLUTE MAXIMUM RATINGS($T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Values	Unit
V_{RRM}	Repetitive Reverse Voltage	$T_J=25^\circ\text{C}$	1200	V
$I_{F(AV)}$	Average Forward Current	$T_C=25^\circ\text{C}$	150	
I_{FRM}	Repetitive Peak Forward Current	$t_p=1\text{ms}$	300	A
I^2t		$T_J=125^\circ\text{C}$, $t=10\text{ms}$, $V_R=0\text{V}$	4350	

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IGBT-inverter**ELECTRICAL CHARACTERISTICS** ($T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit
$V_{GE(\text{th})}$	Gate Emitter Threshold Voltage	$V_{CE}=V_{GE}$, $I_C=6\text{mA}$	5.0	5.8	6.5	V
$V_{CE(\text{sat})}$	Collector Emitter Saturation Voltage	$I_C=150\text{A}$, $V_{GE}=15\text{V}$, $T_J=25^\circ\text{C}$		1.7	2.15	
		$I_C=150\text{A}$, $V_{GE}=15\text{V}$, $T_J=125^\circ\text{C}$		1.9		
I_{CES}	Collector Leakage Current	$V_{CE}=1200\text{V}$, $V_{GE}=0\text{V}$, $T_J=25^\circ\text{C}$			100	μA
		$V_{CE}=1200\text{V}$, $V_{GE}=0\text{V}$, $T_J=125^\circ\text{C}$			10	mA
I_{GES}	Gate Leakage Current	$V_{CE}=0\text{V}$, $V_{GE}=\pm 15\text{V}$, $T_J=25^\circ\text{C}$	-400		400	nA
R_{gint}	Integrated Gate Resistor			5		Ω
Q_g	Gate Charge	$V_{CE}=600\text{V}$, $I_C=150\text{A}$, $V_{GE}=\pm 15\text{V}$		1.4		μC
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}$, $V_{GE}=0\text{V}$, $f=1\text{MHz}$		10.5		nF
C_{res}	Reverse Transfer Capacitance			400		nF
$t_{d(on)}$	Turn on Delay Time	$V_{CC}=600\text{V}$, $I_C=150\text{A}$	$T_J=25^\circ\text{C}$	260		ns
		$R_G=2.4\Omega$, $V_{GE}=\pm 15\text{V}$,	$T_J=125^\circ\text{C}$	290		ns
t_r	Rise Time	Inductive Load	$T_J=25^\circ\text{C}$	30		ns
			$T_J=125^\circ\text{C}$	50		ns
$t_{d(off)}$	Turn off Delay Time	$V_{CC}=600\text{V}$, $I_C=150\text{A}$	$T_J=25^\circ\text{C}$	420		ns
		$R_G=2.4\Omega$, $V_{GE}=\pm 15\text{V}$,	$T_J=125^\circ\text{C}$	520		ns
t_f	Fall Time	Inductive Load	$T_J=25^\circ\text{C}$	70		ns
			$T_J=125^\circ\text{C}$	90		ns
E_{on}	Turn on Energy	$V_{CC}=600\text{V}$, $I_C=150\text{A}$	$T_J=25^\circ\text{C}$	12		mJ
		$R_G=2.4\Omega$, $V_{GE}=\pm 15\text{V}$,	$T_J=125^\circ\text{C}$	16		mJ
E_{off}	Turn off Energy	Inductive Load	$T_J=25^\circ\text{C}$	11		mJ
			$T_J=125^\circ\text{C}$	14.5		mJ
I_{sc}	Short Circuit Current	$tpsc \leq 10\mu\text{s}$, $V_{GE}=15\text{V}$ $T_J=125^\circ\text{C}$, $V_{CC}=900\text{V}$		600		A
R_{thJC}	Junction to Case Thermal Resistance (Per IGBT)				0.2	K/W

Diode-inverter**ELECTRICAL CHARACTERISTICS** ($T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit
V_F	Forward Voltage	$I_F=150\text{A}$, $V_{GE}=0\text{V}$, $T_J=25^\circ\text{C}$		1.65	2.15	V
		$I_F=150\text{A}$, $V_{GE}=0\text{V}$, $T_J=125^\circ\text{C}$		1.65		
t_{rr}	Reverse Recovery Time	$I_F=150\text{A}$, $V_R=600\text{V}$		260		ns
I_{RRM}	Max. Reverse Recovery Current	$dl_F/dt=-4000\text{A}/\mu\text{s}$		210		A
Q_{RR}	Reverse Recovery Charge	$T_J=125^\circ\text{C}$		30		μC
E_{rec}	Reverse Recovery Energy			13		mJ
R_{thJCD}	Junction to Case Thermal Resistance (Per Diode)			0.36		K/W

NTC CHARACTERISTICS ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions	Min.	Typ.	Max.	Unit
R_{25}	Resistance		25°C	5	$\text{k}\Omega$
$B_{25/50}$	$R_2 = R_{25} \exp [B_{25/50}(1/T_2 - 1/(298.15 \text{ K}))]$			3375	K

MODULE CHARACTERISTICS ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions	Values	Unit
T_{Jmax}	Max. Junction Temperature	150	$^\circ\text{C}$
T_{Jop}	Operating Temperature	-40~125	
T_{stg}	Storage Temperature	-40~125	
V_{isol}	Isolation Breakdown Voltage	AC, 50Hz(R.M.S), t=1minute	V
CTI	Comparative Tracking Index	>225	
Md	Mounting Torque	Recommended (M5)	Nm
Weight		2.5~5	
		300	g

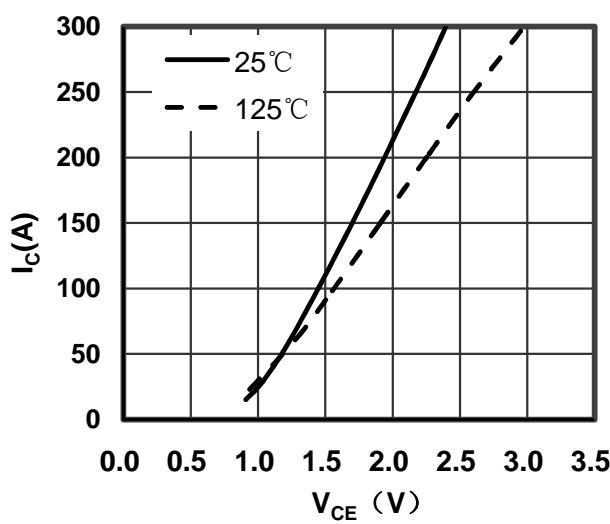


Figure 1. Typical Output Characteristics
IGBT-inverter

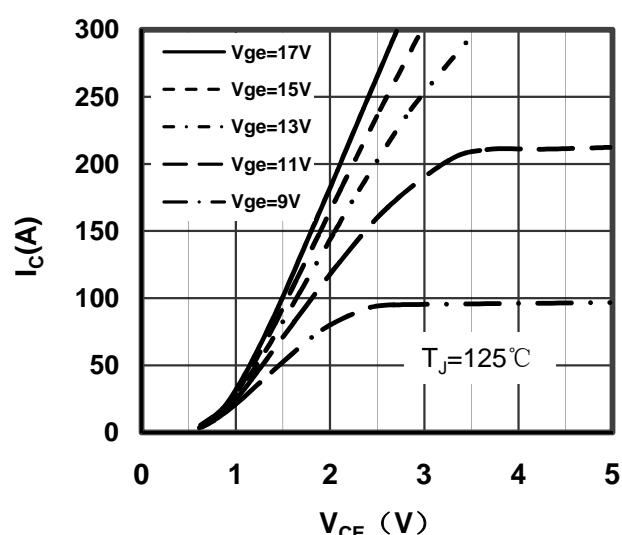


Figure 2. Typical Output Characteristics
IGBT-inverter

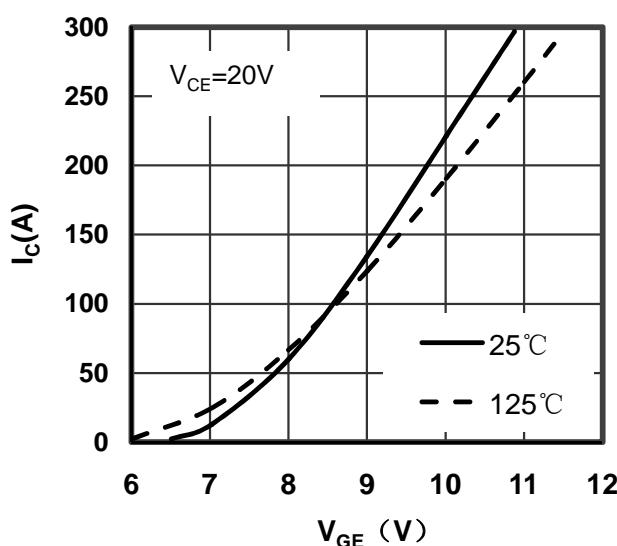


Figure 3. Typical Transfer Characteristics
IGBT-inverter

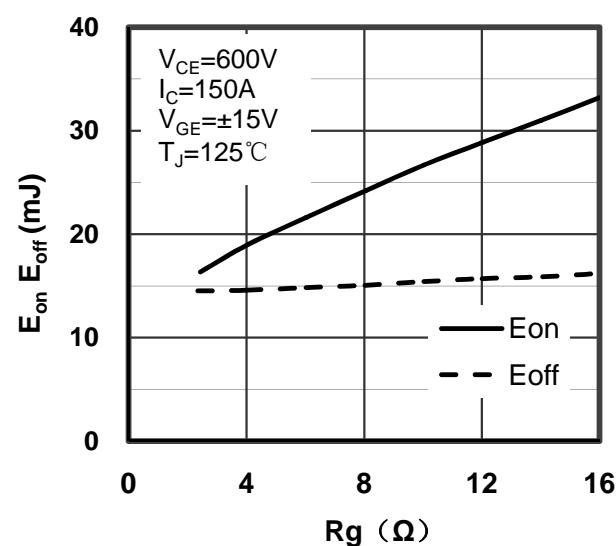


Figure 4. Switching Energy vs Gate Resistor
IGBT-inverter

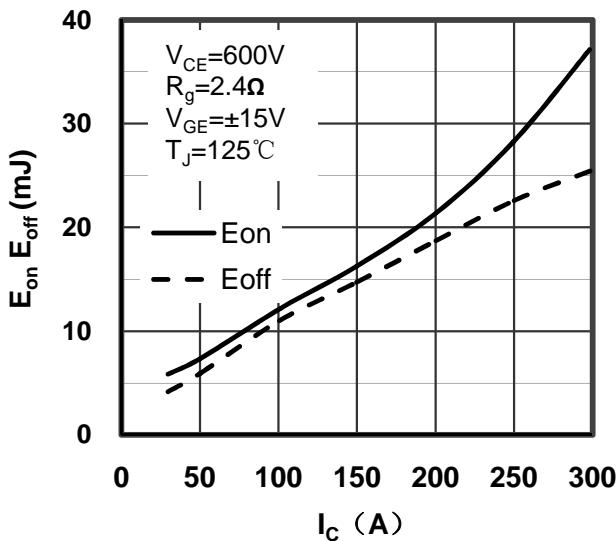


Figure 5. Switching Energy vs Collector Current
IGBT-inverter

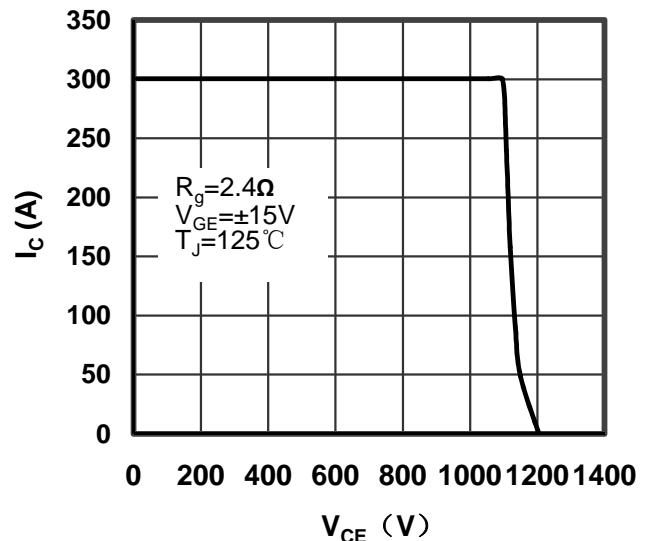


Figure 6. Reverse Biased Safe Operating Area
IGBT-inverter

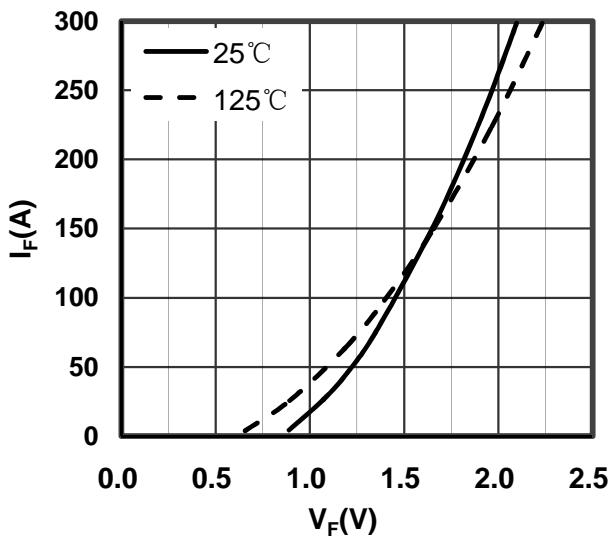


Figure 7. Diode Forward Characteristics
Diode -inverter

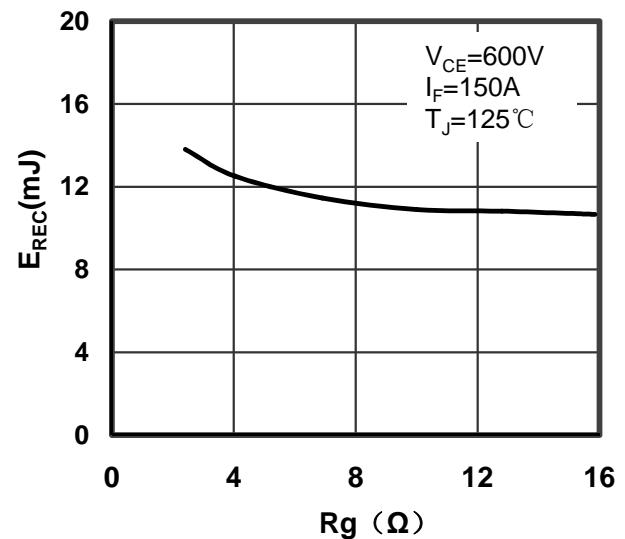


Figure 8. Switching Energy vs Gate Resistor
Diode -inverter

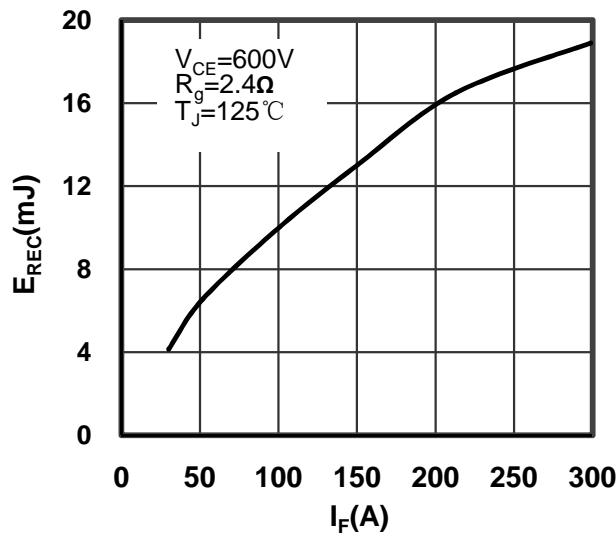


Figure 9. Switching Energy vs Forward Current
Diode-inverter

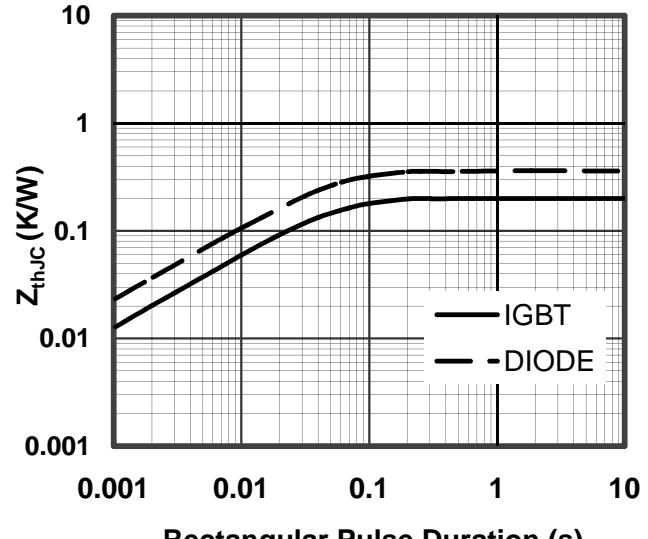


Figure 10. Transient Thermal Impedance of
Diode and IGBT-inverter

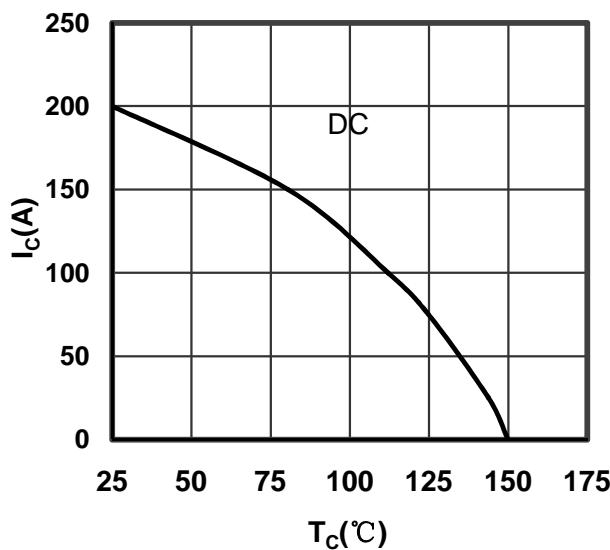


Figure 11. Collector Current vs Case temperature
IGBT -inverter

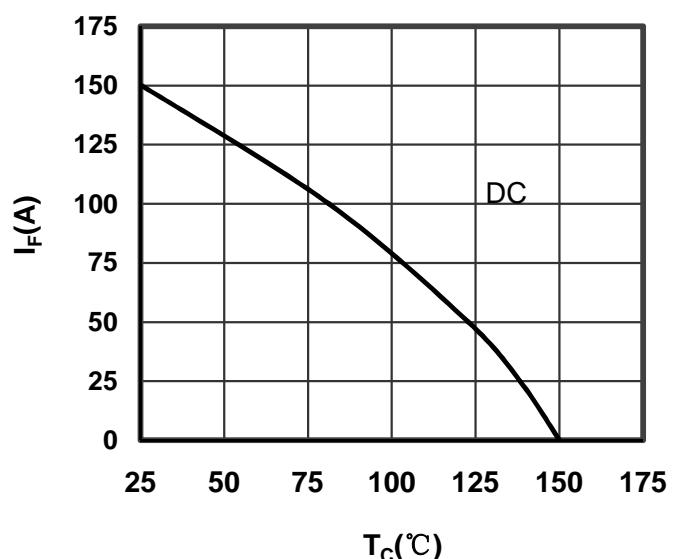


Figure 12. Forward current vs Case temperature
Diode -inverter

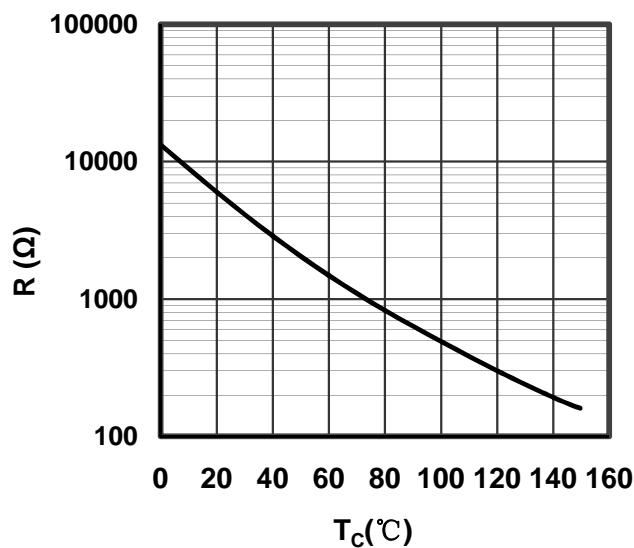


Figure 13. NTC Characteristics

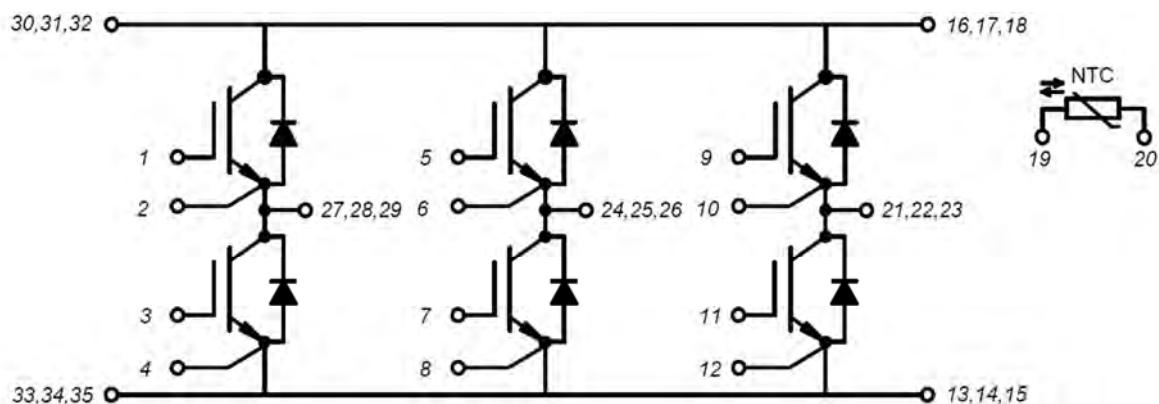
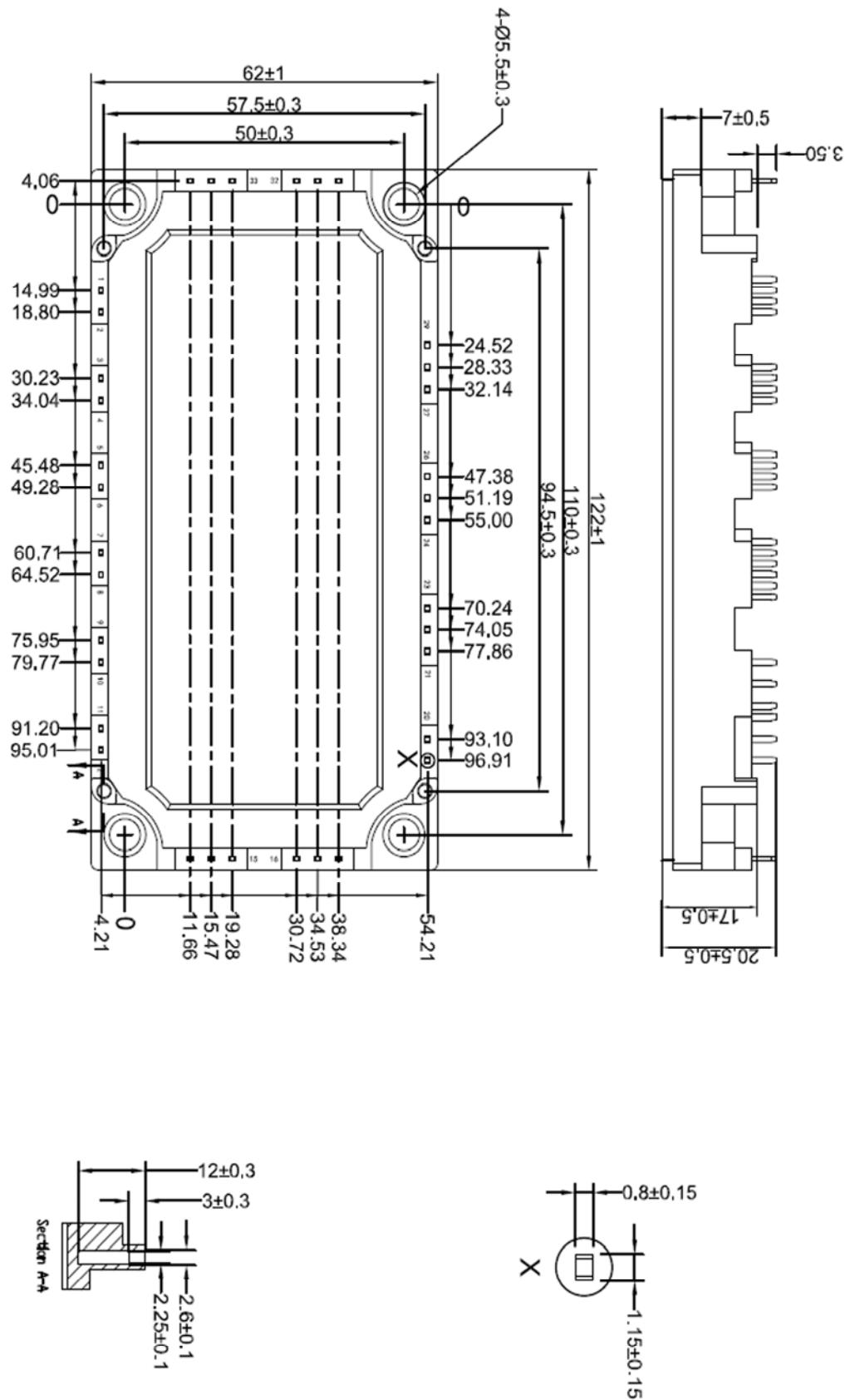


Figure 14. Circuit Diagram



Dimensions in (mm)
Figure 15. Package Outline